

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination SCHEIDMANTAL ET AL.	
		Examiner Greg Blankenship	Art Unit 3612	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,568,743	05-2003	Jayasuriya et al.	296/153
	B	US-6,409,249	06-2002	Han, Kyung-Sik	296/146.7
	C	US-6,213,538	04-2001	Scheidmantel et al.	296/153
	D	US-6,183,038	02-2001	Hansen et al.	296/146.7
	E	US-5,967,594	10-1999	Ramanujam, Narayanan	296/153
	F	US-5,857,702	01-1999	Suga et.al.	280/751
	G	US-5,573,272	11-1996	Teshima, Kouya	280/751
	H	US-5,527,084	06-1996	Scherf, Ansgar P. T.	296/153
	I	US-5,445,430	08-1995	Nichols, Lawrence R.	296/153
	J	US-5,181,759	01-1993	Doolittle, Edson P.	296/153
	K	US-4,786,100	11-1988	Kleemann et al.	296/146.6
	L	US-4,783,114	11-1988	Welch, Jeffrey A.	296/153
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.